Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/052,744	RAPP ET AL.	
Examiner	Art Unit	
Karen C. Tang	2151	

SEARCHED					
Class	Subclass	Date	Examiner		
709	220	7/18/2007	кт		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH I (INCLUDING SEAR		·)
	DATE	EXMR
See East Search Notes	7/18/2007	кт
See Inventor Search Notes	7/18/2007	кт